

<b>Notice of References Cited</b>	Application/Control No. 10/529,209	Applicant(s)/Patent Under Reexamination INOUE, NAOYUKI	
	Examiner Mohammad M. Ali	Art Unit 3744	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,570,456	02-1986	Reimann et al.	62/476
*	B	US-5,263,340	11-1993	Sekoguchi et al.	62/497
*	C	US-5,381,674	01-1995	Omori et al.	62/497
*	D	US-5,544,497	08-1996	Inoue, Naoyuki	62/497
*	E	US-4,183,228	01-1980	Saito et al.	62/497
*	F	US-4,487,036	12-1984	Itoh et al.	62/474
*	G	US-3,175,371	03-1965	STANLEY HARWICH	62/101
*	H	US-3,495,420	02-1970	LOWETH CARL V; et. al.	62/476
*	I	US-3,550,394	12-1970	PECKHAM DAVID G	62/485
*	J	US-3,651,654	03-1972	Rachfal, Stanley J.	62/103
*	K	US-3,710,852	01-1973	Porter, James M.	165/62
*	L	US-3,721,109	03-1973	Porter, James M.	62/476
*	M	US-4,085,595	04-1978	Saito et al.	62/476

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0853220 A2	07-1998	Europe	Takaishi et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.